

Search Notes

Application/Control No.

10/690,324

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2619

SEARCHED

Class	Subclass	Date	Examiner
370	535-537	3/4/2008	MAM
	539 540		
	541 542		
	544		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See inventorship Search	3/4/2008	MAM
See Attached Electronic Search	3/4/2008	MAM